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THE UNITED STATES PATENT AND TRADEMARK OFFICE

ATTY.'S DOCKET: NYGARD=3

In re Application of:	)	Art Unit: 2878
	)	
Einar NYGARD	)	Examiner: P. LEE
	)	
Appln. No.: 10/506,497	)	Washington, D.C.
	)	
Filed: September 3, 2004	)	Confirmation No. 1569
	)	
For: PIXEL SENSOR ARRAY HAVING	)	August 21, 2006
A LAYER OF SENSOR...	)	

IDS CORRECTION

Honorable Commissioner for Patents  
Customer Service Window  
Randolph Building, Mail Stop ISSUE FEE  
401 Dulany Street  
Alexandria, VA 22314

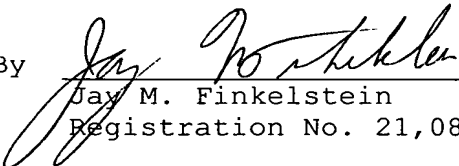
Sir:

A review of the IDS filed on January 14, 2005, has revealed a typographical error in the form SB/08A/B which is a part thereof. The correct patent number of document AA is 4,104,674, rather than the number listed on the form SB/08A/B. Submitted herewith is a corrected form SB/08A/B.

Applicant respectfully requests that this correction be made of record in the above-identified application.

Respectfully submitted,

BROWDY AND NEIMARK, P.L.L.C.  
Attorneys for Applicant

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Substitute for form 1449A/PTO

**INFORMATION DISCLOSURE  
STATEMENT BY APPLICANT**

(use as many sheets as necessary)

Sheet 1 of 1

**Complete if Known**

Application Number	10/506,497
Filing Date	September 3, 2004
First Named Inventor	Einar NYGARD
Group Art Unit	
Examiner Name	
Attorney Docket Number	NYGARD=3

**U.S. PATENT DOCUMENTS**

Examiner Initials*	Cite No. <sup>1</sup>	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code <sup>2</sup> (if known)			
	AA	US-4,104,674	08-01-1978	LORENZE, Jr., et al	
	AB	US-4,547,792	10-15-1985	SCLAR	
	AC	US-4,857,746	08-15-1989	KUHLMANN et al	
	AD	US-5,254,868 A	10-19-1993	SAITO	
	AE	US-5,998,292 A	12-07-1999	BLACK et al	
		US-			
		US-			

**FOREIGN PATENT DOCUMENTS**

Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Number		Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T <sup>6</sup>
		Country Code <sup>3</sup>	Number <sup>4</sup> Kind Code <sup>5</sup> (if known)				
	AF	JP	61-128564 A2	06-16-1986	FUJITSU LTD.		Abs
	AG	EP	0 415 541 A1	03-06-1991	SHIMADZU CORPORATION		
	AH	EP	0 537 514 A2	04-21-1993	MITSUBISHI DENKI KABUSHIKI KAISHA		
	AI	EP	1 045 450 A2	10-18-2000	AGLLENT TECHNOLOGIES INC.		

**OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS**

Examiner Initials*	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published	T <sup>2</sup>
	AJ	BENTHIEN, et al, "A Vertically Integrated High Resolution Active Pixel Image Sensor for Deep Submicron CMOS Processes", IEEE Workshop on CCDs and Advanced Image Sensors, Nagano, Japan, June 10-12, 1999.	

Examiner  
SignatureDate  
Considered

\* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. <sup>1</sup> Applicant's unique citation designation number (optional). <sup>2</sup> See Kind Codes of USPTO Patent Documents at [www.uspto.gov](http://www.uspto.gov) or MPEP 901.04. <sup>3</sup> Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). <sup>4</sup> For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. <sup>5</sup> Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. <sup>6</sup> Applicant is to place a check mark here if English language Translation is attached.